

**Search Notes**

Application/Control No.

10/611,871

Examiner

Daniel F. Hajnik

Applicant(s)/Patent under  
Reexamination

KONYA ET AL.

Art Unit

2671

**SEARCHED**

Class	Subclass	Date	Examiner
345	419	6/30/2005	DFH
382	154	7/6/2005	DFH
715	706	7/6/2005	DFH
348	42	7/6/2005	DFH
348	49	7/6/2005	DFH
345	418	7/6/2005	DFH
345	629	7/7/2005	DFH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
345	418, 419	7/6/2005	DFH
348	42, 49	7/6/2005	DFH
715	706	7/6/2005	DFH
345/629, 382/154		7/7/2005	DFH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor name search performed no double patenting found	6/29/2005	DFH
EAST Text Search performed (attached)	7/6/2005	DFH
ACM search performed and attached	7/6/2005	DFH
IEEE search performed and attached	7/6/2005	DFH
Interference search performed with PGPUB	7/7/2005	DFH
Classes 345/419, 382/154, 715/706, 348/42, 49, 345/418, 629 combined with text search	7/7/2005	DFH
Consulted and reviewed relevant prior art with Supervising Primary Examiner Richard Hjerpe	7/7/2005	DFH